

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination LANDA ET AL.	
		09/849,467	Examiner	Art Unit Christopher M. Keehan 1712

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-5,629,101	05-1997	Watremez, Michel	428/701
	B	US-4,537,299	08-1985	Fukatani, Yasunobu	192/107C
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
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	K	US-			
	L	US-			
	M	US-			

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